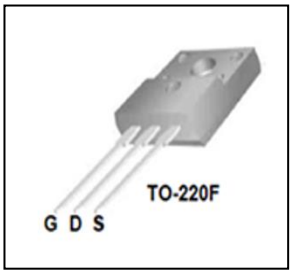
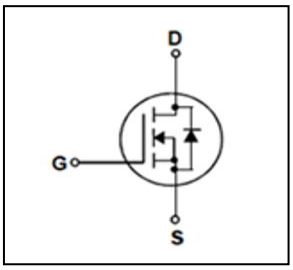
900V N-Channel MOSFET

General Description

This Power MOSFET is produced using advanced planar stripe DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode.
These devices are well suited for high efficiency switched mode power supplies, active power factor correction based on half bridge topology.





Features

7A, 900V, R_{DS}(on)typ. = 1. 65Ω@VGS = 10 V
Low gate charge (41.5nC)
High ruggedness
Fast switching
Improved dv/dt capability

Absolute Maximum Ratings T_C = 25 ℃ unless otherwise noted

Symbol	Parameter		JFFM7N90C	Units
V_{DSS}	Drain – Source Voltage		900	V
I_D	Drain Current	Continuous (T_C = 25 ℃)	7	A
		Continuous (T_C = 100 ℃)	4*	A
I_{DM}	Drain Current - Pulsed	(Note 1)	28	A
V_{GSS}	Gate – Source Voltage		±30	V
EAS	Single Pulsed Avalanche Energy	(Note 2)	258	mJ
I_{AR}	Avalanche Current	(Note 1)	7	A
E_{AR}	Repetitive Avalanche Energy	(Note 1)	20	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	5.0	V/ns
P_D	Power Dissipation (T_C = 25 ℃)		48	W
	-Derate above 25 ℃		0.364	W/℃
T_J,T_{STG}	Operating and Storage Temperature Range		-55~150	℃
T_L	Maximum lead temperature for soldering purposes 1/8” frome case for 5 seconds		300	℃

*Drain current limited by maximum junction temperature.

Thermal characteristics

Symbol	Parameter	JFFM7N90C	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	2.6	℃/W
$R_{\theta JS}$	Thermal Resistance, Case-to-Sink Typ.	--	℃/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62.5	℃/W

Electrical Characteristics T_C = 25 ℃ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
Off Characteristics						
BV_{DSS}	Drain – Source Breakdown Voltage	V_{GS} = 0 V, I_D = 250 uA	900	--	--	V
$\Delta BV_{DSS}/\Delta T_J$	Breakdown Voltage Temperature Coefficient	I_D = 250 uA, Referenced to 25℃	--	0.65	--	V/℃
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS} = 900 V, V_{GS} = 0 V	--	--	1	uA
		V_{DS} = 720 V, Tj = 125 ℃	--	--	10	uA
I_{GSSF}	Gate-Body Leakage Current, Forward	V_{GS} = 30 V, V_{GS} = 0 V	--	--	100	nA
I_{GSSR}	Gate-Body Leakage Current, Reverse	V_{GS} = -30 V, V_{GS} = 0 V	--	--	-100	nA
On Characteristics						
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS} = V_{GS}, I_D = 250 uA	3.0	--	5.0	V
$R_{DS(on)}$	Static Drain-Source on-Resistance	V_{GS} = 10 V, I_D = 3.5A	--	1.65	2.15	Ω
g_{FS}	Forward Transconductance	V_{DS} = 20 V, I_D = 3.5 A (Note 4)	--	8.2	--	S
Dynamic Characteristics						
C_{iss}	Input Capacitance	V_{DS} = 25 V, V_{GS} = 0 V, f = 1.0 MHz	--	1540	--	pF
C_{oss}	Output Capacitance		--	108	--	pF
C_{rss}	Reverse Transfer Capacitance		--	8.19	--	pF
Switching Characteristics						
$t_{d(on)}$	Turn-On Delay Time	V_{DS} = 520 V, I_D = 7.0 A , R_G = 25Ω , V_{GS} = 10 V (Note 4,5)	--	19	--	ns
t_r	Turn-On Rise Time		--	15	--	ns
$t_{d(off)}$	Turn-Off Delay Time		--	80	--	ns
t_f	Turn-Off Fall Time		--	22	--	ns
Q_g	Total Gate Charge	V_{DS} = 630 V, I_D = 7.0 A V_{GS} = 10 V (Note 4,5)	--	41.5	--	nC
Q_{gs}	Gate-Source Charge		--	8.15	--	nC
Q_{gd}	Gate-Drain Charge		--	14.95	--	nC
Drain – Source Diode Characteristics and Maximum Ratings						
I_S	Maximum Continuous Drain-Source Diode Forward Current		--	--	7	A
I_{SM}	Maximum Pulsed Drain-Source Diode Forward Current		--	--	28	A
V_{SD}	Drain-Source Diode Forward Voltage	V_{GS} = 0 V, I_S = 7.0 A	--	0.87	1.5	V
t_{rr}	Reverse Recovery Time	V_{GS} = 0 V, I_S = 7.0 A dI_F/dt = 100 A/us (Note 4)	--	330	--	ns
Q_{rr}	Reverse Recovery Charge		--	2.5	--	uC

Notes:

1. Repetitive Rating : Pulsed width limited by maximum junction temperature
2. L = 10mH , I_{AS} = 7A, V_{DD} = 50V,R_G = 25Ω, Starting T_J = 25℃
3. I_{SD} ≤ 7.0A, di/dt ≤ 200A/us, V_{DD} ≤ BV_{DSS}, Starting T_J = 25°C
4. Pulsed Test : Pulsed width ≤300us, Duty cycle ≤ 2%
5. Essentially independent of operating temperature

Typical Characteristics

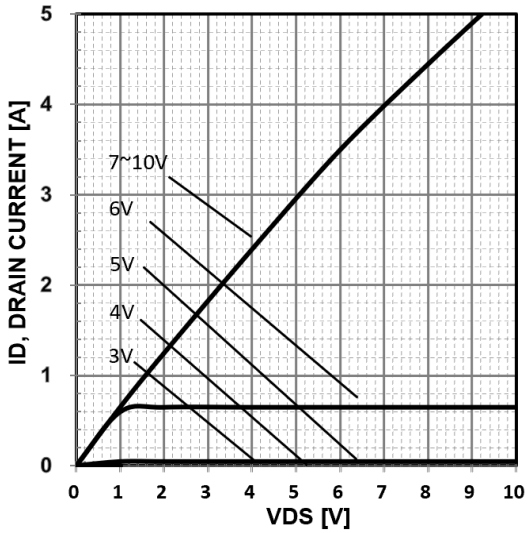


Figure 1. Typical Output Characteristics, Tc=25℃

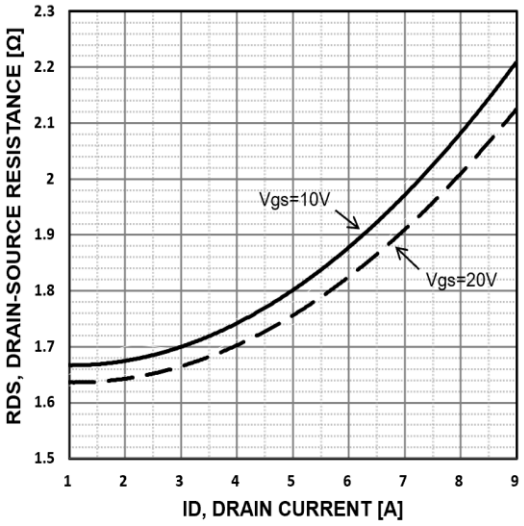


Figure 2. On-Resistance Vs.Drain Current and Gate Voltage

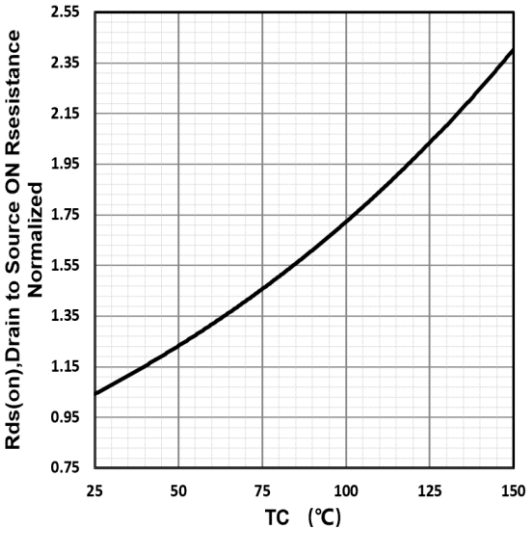


Figure 3. Normalized On-Resistance Vs.Temperature

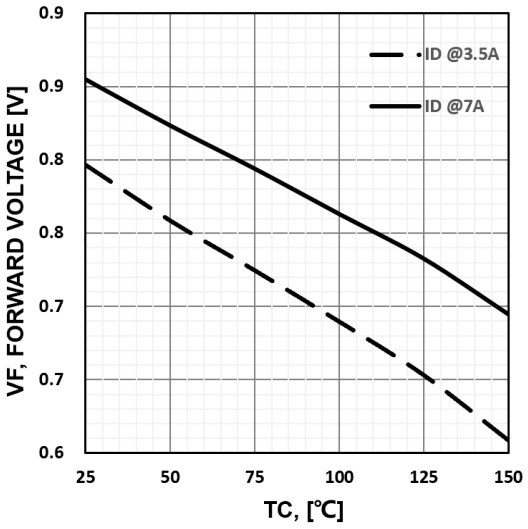


Figure 4. Forward Voltage Vs.Temperature

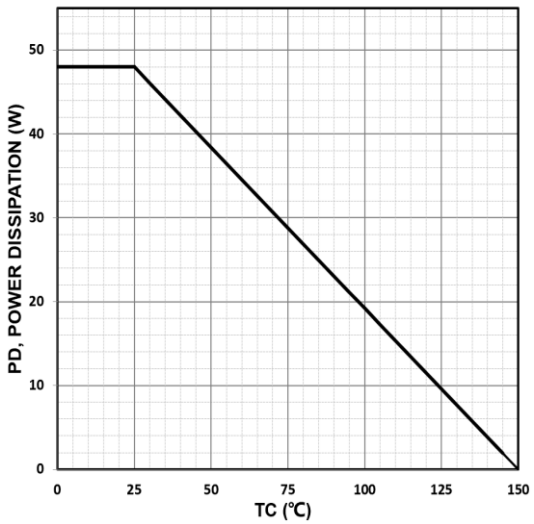


Figure 5. Power Dissipation Vs.Temperature

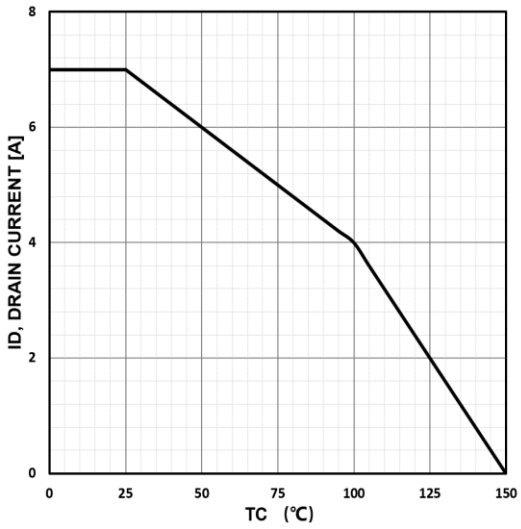


Figure 6. Drain Current Vs.Temperature

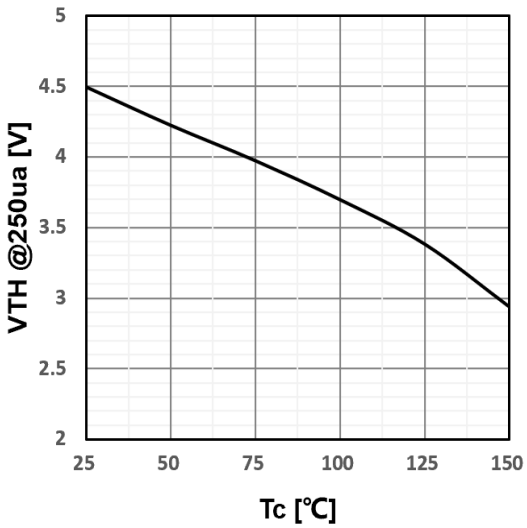


Figure 7. Vth @250ua Vs.Temperature

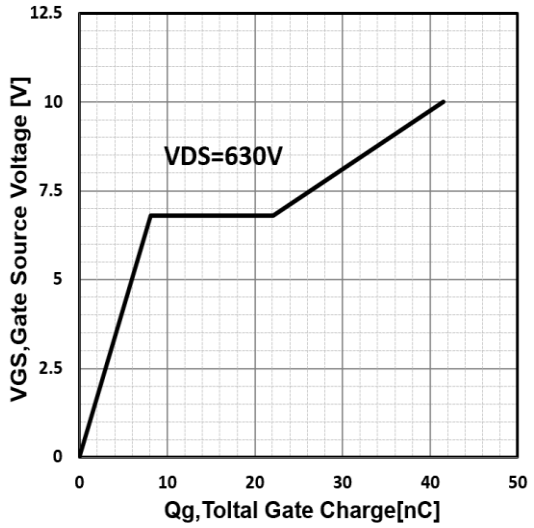


Figure 8. Gate Charge

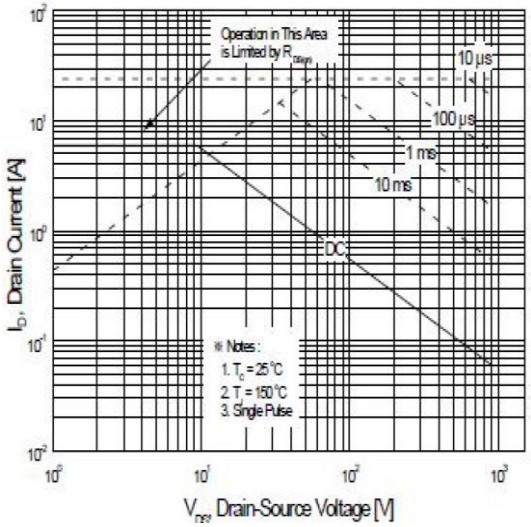
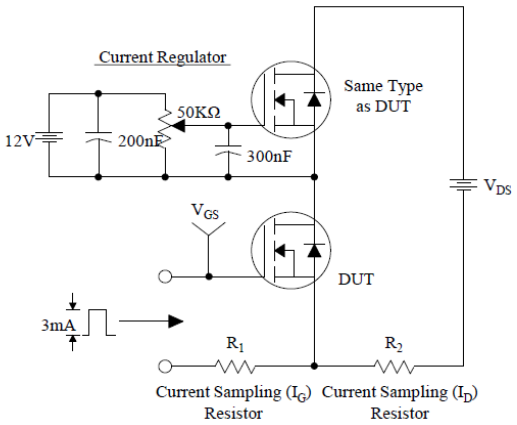
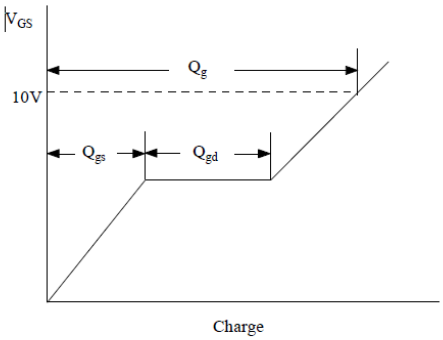


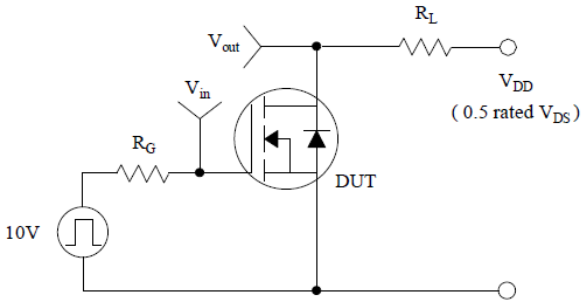
Figure 9. Maximum Safe Operating Area

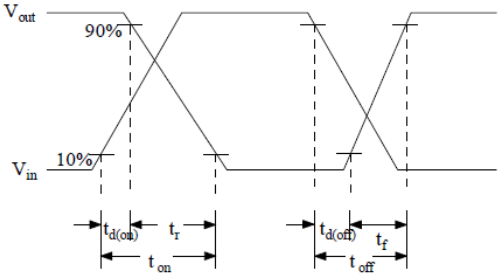
Test Circuit & Waveform



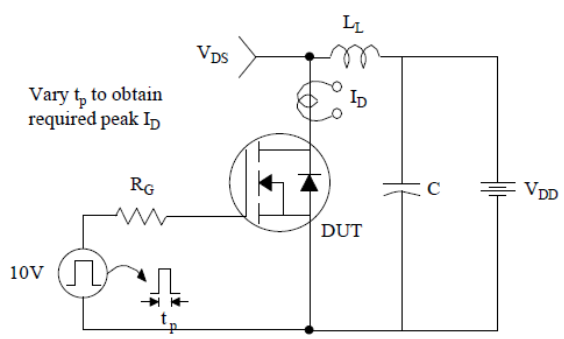


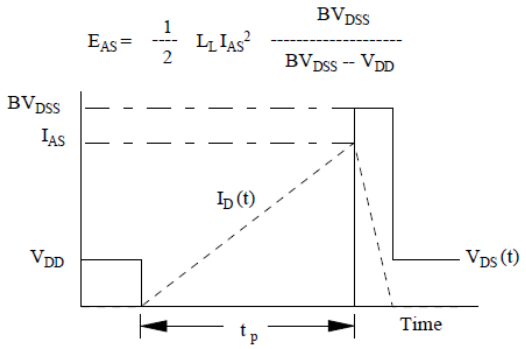
Gate Charge Test Circuit & Waveform





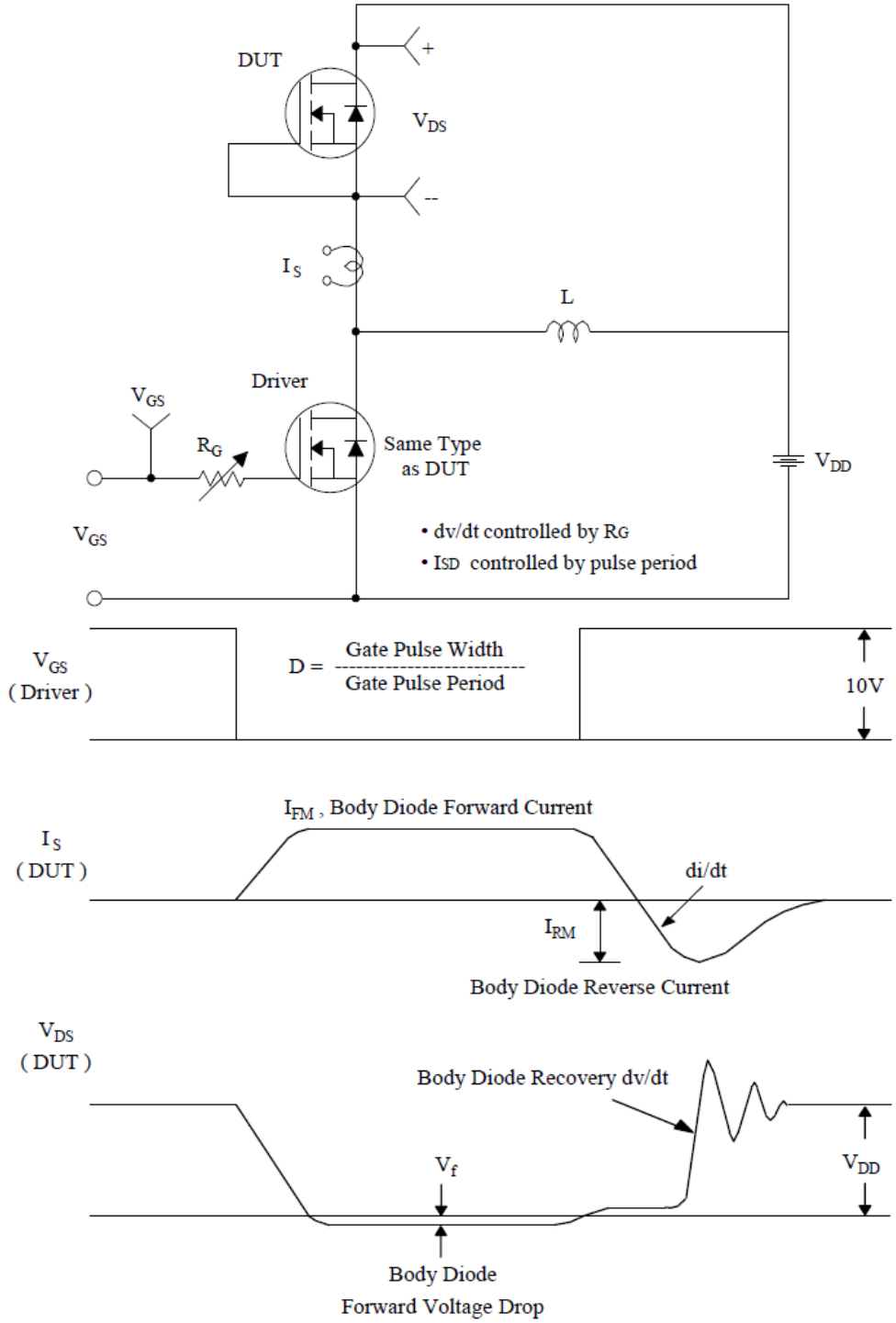
Resistive Switching Test Circuit & Waveforms





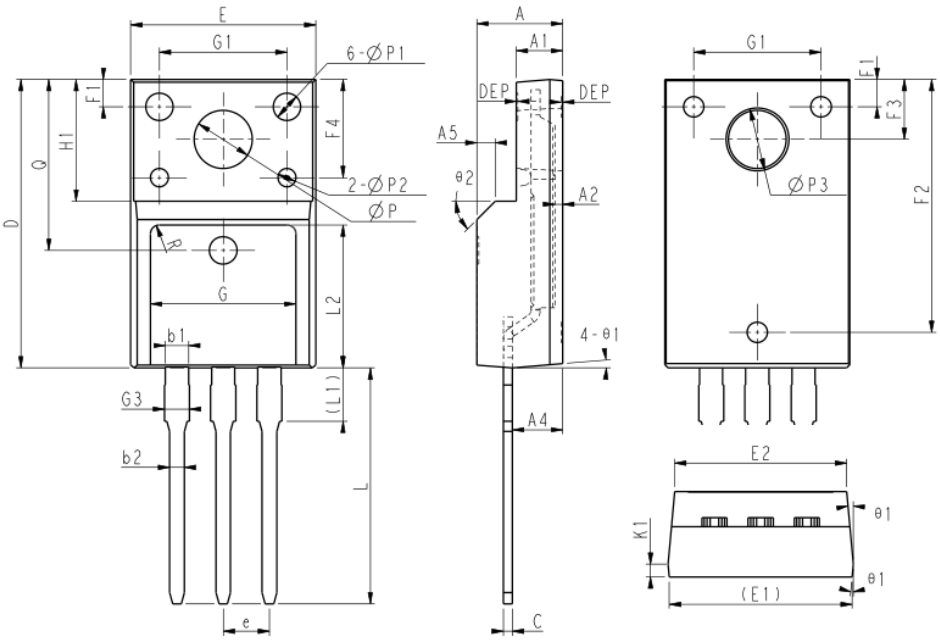
Unclamped Inductive Switching Test Circuit & Waveforms

Test Circuit & Waveform



Peak Diode Recovery dv/dt Test Circuit & Waveforms

TO-220F Package



COMMON DIMENSIONS

SYMBOL	MM		
	MIN	NOM	MAX
E	10.00	10.16	10.32
E1	9.94	10.04	10.14
E2	9.36	9.46	9.56
A	4.50	4.70	4.90
A1	2.34	2.54	2.74
A2	0.43	-	0.48
A4	2.66	2.76	2.86
A5		1.00REF	
c	0.45	0.50	0.60
D	15.67	15.87	16.07
Q		9.40REF	
H1		6.70REF	
e		2.54BSC	
ΦP		3.18REF	
L	12.78	12.98	13.18
L1	2.83	2.93	3.03
L2	7.70	7.80	7.90
ΦP1	1.40	1.50	1.60
ΦP2	0.95	1.00	1.05
ΦP3		3.45REF	
θ1	3°	5°	7°
θ2	-	45°	-
DEP	0.05	0.10	0.15
F1	1.00	1.50	2.00
F2	13.80	13.90	14.00
F3	3.20	3.30	3.40
F4	5.30	5.40	5.50
G	7.80	8.00	8.20
G1	6.90	7.00	7.10
G3	1.25	1.35	1.45
b1	1.23	1.28	1.38
b2	0.75	0.80	0.90
K1	0.65	0.70	0.75
R		0.50REF	

Disclaimers

JIAEN Semiconductor Co., Ltd reserves the right to make changes without notice in order to improve reliability, function or design and to discontinue any product or service without notice. Customers should obtain the latest relevant information before orders and should verify that such information is current and complete. All products are sold subject to JIAEN's terms and conditions supplied at the time of order acknowledgement.

JIAEN Semiconductor Co., Ltd warrants performance of its hardware products to the specifications at the time of sale, Testing, reliability and quality control are used to the extent JIAEN deems necessary to support this warrantee. Except where agreed upon by contractual agreement, testing of all parameters of each product is not necessarily performed.

JIAEN Semiconductor Co., Ltd does not assume any liability arising from the use of any product or circuit designs described herein. Customers are responsible for their products and applications using JIAEN's components. To minimize risk, customers must provide adequate design and operating safeguards.

JIAEN Semiconductor Co., Ltd does not warrant or convey any license either expressed or implied under its parent rights, nor the rights of others. Reproduction of information in JIAEN's datasheets or data books sis permissible only if reproduction is without modification or alteration. Reproduction of this information with any alteration is an unfair and deceptive business practice. JIAEN Semiconductor Co., Ltd is not responsible or liable for such altered documentation.

Resale of JIAEN's products with statements different from or beyond the parameters stated by JIAEN Semiconductor Co., Ltd for that product or service voids all express or implied warrantees for the associated JIAEN's product or service and is unfair and deceptive business practice. JIAEN Semiconductor Co., Ltd is not responsible or liable for any such statements.